

#### 12500 TI Boulevard, MS 8640, Dallas, Texas 75243

# PCN#20191101000.1 Qualification of CDAT as an additional assembly site for select QFN devices Change Notification / Sample Request

**Date:** January 29, 2020

Dear TI Customer:

This is an announcement of a change to a device that is currently offered by Texas Instruments. The details of this change are on the following pages.

The customer should acknowledge receipt of this notification by email within **30** days of the date of receipt. Lack of acknowledgement of this notice within 30 days constitutes customer acceptance of the change.

Samples or additional data to support customer evaluation must be requested within 30 days of receipt of this notification. If samples are requested for evaluation the customer must provide evaluation results within the sample evaluation period indicated on page 3 of this notification. The Sample Evaluation Period begins on the date the customer receives samples from TI.

If the customer approved the change TI can proceed with implementation of the change. The proposed first ship date is shown on page 3.

If the customer does not approve the PCN or the approval response is not provided within the Sample Evaluation Period, TI can implement the change, but the customer may elect to place an order for unchanged product by the Last Time Buy Date for delivery by the Last Time Ship Date. TI cannot guarantee that shipments to the customer after any last time order is delivered will not include the changed material. If the customer places an order with delivery after the Last Time Shipment Date, the order may be fulfilled with changed material or any material processed to TI specifications at that future time.

This notice does not change the end-of-life status of any product. Should product affected be on a previously issued product withdrawal/discontinuance notice, this notification does not extend the life of that product or change the life time buy offering/discontinuance plan.

For questions regarding this notice, contact your local Field Sales Representative or the PCN Team (<u>PCN ww admin team@list.ti.com</u>). For sample requests or sample related questions, contact your field sales representative.

Sincerely, PCN Team SC Business Services

# 20191101000.1 Change Notification / Sample Request Attachments

### **Products Affected:**

The devices listed on this page are a subset of the complete list of affected devices. According to our records, these are the devices that you have purchased within the past twenty-four (24) months. The corresponding customer part number is also listed, if available.

DEVICE	<b>CUSTOMER PART NUMBER</b>
SN74AVC8T245RHLR	36020428
TPS63000DRCR	39140521
TPS63000DRCR	39140521/
TPS63000DRCT	39140521/
TPS63000DRCR	39140521/TPS63000DRCR
TPS63000DRCT	39140521/TPS63000DRCT
TPS63000DRCR	99012BEH
TPS62172DSGT	99053MQR
TPS74801DRCR	HUW3H-MP-00004395-000

Technical details of this Product Change follow on the next page(s).

PCN	Num	mber: 20191101000.1 PCN Date: Jan 29 2020								
Title	e: (	Qualification	of CDAT as	s an a	dditional asse	mbly site f	or s	ele	ct QFN device	es
Cust		Contact:	PCN Manag		Dept:	Quality Se				
Prop		1st Ship	Apr 28 20	)20	Sample Eval Period:	90 days				
Last Date	: Time e:	Buy	Jun 28 2	020	Last Time Ship Date:	Sept 28 2	020			
Cha	nge T	ype:								
	Assen	nbly Site			Design				Wafer Bump	Site
	Assen	nbly Process			Data Sheet				Wafer Bump	Material
	Assen	nbly Materia	ls		Part number	change			Wafer Bump	Process
	Mecha	anical Specif	ication		Test Site				Wafer Fab S	Site
	Packir	ng/Shipping/	'Labeling		Test Process				Wafer Fab M	1aterials
									Wafer Fab P	rocess
					PCN Deta	ails				
Des	cripti	on of Chan	ge:							
site as fo	for the	e list of QFN	devices sh		nce the qualification control of the	t assembly				differences are
	-	Mold Comp	nund						4222198	<del> </del>
	-	Mold Compo			4208625				4222198	<del> </del>
	L	Mount Com	pouriu		4205846			420/123		
Gro	up 2 I	30M compa	rison:	•					_	
					MLA	Clark			CDAT	
		Mold Comp	ound		4208625	4208625			4222198	
		Mount Com	pound		4205846	42077	58		4207123	
		2014		•					•	
Gro	up 3 i	BOM compa	rison:		ML	Δ			CDAT	
		Mold Compo	ound .						4222198	
		Mount Com			4208625 4212088		4207123		<del></del>	
	_	Mount Com	pouriu		7212	000			420/123	
Rea	son fo	or Change:								
Cont	inuity	of Supply								
	<u>·</u>		on Form, F	it, Fu	ınction, Qua	lity or Reli	abi	lit	y (positive /	negative):
None	e	-		-		-			-	
		ed impact o	on Materia	al Dec	laration					
		npact to the				ns or Produ	ct C	on	tent reports a	are driven
	No Impact to the Material Declaration  Material Declaration  Material Declaration  Material Declaration from production data and will be available following the production release. Upon production release the revised reports can be obtained at the site link below <a href="http://www.ti.com/quality/docs/materialcontentsearch.tsp">http://www.ti.com/quality/docs/materialcontentsearch.tsp</a>					ng the revised				

# Changes to product identification resulting from this PCN:

Assembly Site	Assembly Site Origin (22L)	Assembly Country Code (23L)	<b>Assembly City</b>
MLA	MLA	MYS	Kuala Lumpur
CLARK	QAB	PHL	Angeles City, Pampanga
CDAT	CDA	CHN	Chengdu

Sample product shipping label (not actual product label)



PTEM: 39 LBL: 5A (L)TO:1750



(1P) \$N74L\$07N\$R (Q) 2000 (D) 0336 (31T)LOT: 3959047MLA (4W) TKY(1T) 7523483\$I2 (P) (2P) REV: (V) 0033317 (20L) C\$0: SHE (21L) CCO:USA (22L) A\$0: MLA (23L) ACO: MY\$

**Product Affected:** 

**Group 1 Device List (Current MLA Assembly, add CDAT):** 

SN74AVC8T245RHLR TPS63000DRCR TPS63000DRCT

Group 2 Device List (Current MLA Assembly & Clark, add CDAT):

TPS74801DRCR

**Group 3 Device List (Current MLA Assembly, add CDAT):** 

TPS62172DSGT

# **Group 1 Qual Memo:**



#### **Qualification Results** Data Displayed as: Number of lots / Total sample size / Total failed

Туре	Test Name / Condition	Duration	Qual Device: E58T245RHLR	QBS Package Reference: BQ24196RGER	QBS Package Reference: BQ29200DRBR	QBS Package Reference: SN74AXC8T245RHLR	QBS Package Reference: TP \$3850G09DRC	QBS Package Reference: TPS62140RGTR	QBS Package Reference: TRS3122ERGER	QBS Package Reference: UCC27282DRC
AC	Autoclave 121C	96 Hours	-	3/231/0	3/231/0	-	3/231/0	3/231/0	3/231/0	3/231/0
ED	Electrical Characterization	Per Datasheet Parameters	-	-	-	Pass	Pass	Pass	Pass	Pass
FLAM	Flammability (IEC 695-2-2)								3/15/0	
FLAM	Flammability (UL 94V-0)								3/15/0	
FLAM	Flammability (UL-1694)								3/15/0	
HAST	Biased HAST, 110C/85%RH	26 Hours	-	-	-	-	-	-	-	1/77/0
HAST	Biased HAST, 130C/85%RH	96 Hours	-	-	-	-	3/231/0	-	3/231/0	2/154/0
HTOL	Life Test, 140C	480 Hours	-	-	-	-	-	-	-	3/231/0
HTOL	Life Test, 150C	300 Hours	-	-	-	-	1/77/0	-	1/77/0	-
HTSL	High Temp Storage Bake 150C	1000 Hours	-	-	•	3/231/0	-	-	3/231/0	3/231/0
HTSL	High Temp Storage Bake 170C	420 Hours	-	-	-	-	3/231/0	-	-	-
SD	Surface Mount Solderability	Pb Free							1/22/0	
TC	Temperature Cycle, -65/150C	500 Cycles	3/231/0	3/231/0	3/231/0	3/231/0	3/231/0	3/231/0	3/231/0	3/231/0
UHAST	Unbiased HAST 130C/85%RH	96 Hours	-	-	-	3/231/0	-	-	-	-
WBP	Bond Pull	Wires	3/228/0	3/228/0	3/228/0	3/228/0	3/228/0	3/228/0	3/228/0	3/228/0
WBS	Ball Bond Shear	Wires	3/228/0	3/228/0	3/228/0	3/228/0	3/228/0	3/228/0	3/228/0	3/228/0

- QBS: Qual By Similarity
   Qual Device E58T245RHLR is qualified at LEVEL1-260CG
   Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable
   The following are equivalent HTOL options based on an activation energy of 0.7eV: 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours
   The following are equivalent HTDL options based on an activation energy of 0.7eV: 150C/1k Hours, and 170C/420 Hours
   The following are equivalent Temp Cycle options per JESD47: 55C/125C/700 Cycles and-65C/150C/500 Cycles
   Quality and Environmental data is available at Ti's external Web site: http://www.ti.com/
   Green/Pb-free Status:
   Qualified Pb-Free(SMT) and Green

# **Group 2 Qual Memo:**



#### **Qualification Results** Data Displayed as: Number of lots / Total sample size / Total failed

Туре	Test Name / Condition	Duration	Qual Device: TPS74801DRCR	QBS Package Reference: 430F2132IRHBR	QBS Package Reference: BQ24196RGER	QBS Package Reference: BQ294504DRVR	QBS Package Reference: <u>TP S51285BRUKR</u>	QBS Package Reference: TRS3122ERGER
AC	Autoclave 121C	96 Hours	-	3/231/0	3/231/0	3/231/0	3/231/0	3/231/0
ED	Electrical Characterization	Per Datasheet Parameters	Pass	-	-	-	-	Pass
FLAM	Flammability (IEC 695- 2-2)		-	-	-	-	-	3/15/0
FLAM	Flammability (UL 94V- 0)		-	-	-	-	-	3/15/0
FLAM	Flammability (UL-1694)		-	-	-	-	-	3/15/0
HAST	Biased HAST, 130C/85%RH	96 Hours	-	-	-	3/231/0	-	3/231/0
HTOL	Life Test, 150C	300 Hours	-	-	-	-	-	1/77/0
HTSL	High Temp Storage Bake 150C	1000 Hours	-	-	-	-	-	3/231/0
SD	Surface Mount Solderability	Pb Free	-	-	-	-	-	1/22/0
тс	Temperature Cycle, - 65/150C	500 Cycles	-	3/231/0	3/231/0	3/231/0	3/231/0	3/231/0
WBP	Bond Pull	Wires	3/228/0	3/228/0	3/228/0	3/228/0	3/228/0	3/228/0
WBS	Ball Bond Shear	Wires	3/228/0	3/228/0	3/228/0	3/228/0	3/228/0	3/228/0

- QBS: Qual By Similarity Qual Device TPS74801DRCR is qualified at LEVEL2-260C
- Quai Device 1PS/480TURCK is qualified at LEVEL2-280C
   Preconditioning was performed for Autodave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable
   The following are equivalent HTOL options based on activation energy of 0.7eV: 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours
   The following are equivalent HTSL options based on an activation energy of 0.7eV: 150C/1k Hours, and 170C/420 Hours
   The following are equivalent Temp Cycle options per JESD47: -55C/125C/700 Cycles and -65C/150C/500 Cycles
   Quality and Environmental data is available at TI's external Web site: http://www.ti.com/

Green/Pb-free Status: Qualified Pb-Free(SMT) and Green

# **Group 3 Qual Memo:**



# Qualification Results Data Displayed as: Number of lots / Total sample size / Total failed

Type To	est Name / Condition	Duration	Qual Device: TP \$62162D SGR	QBS Package Reference: BQ294504DRVR	QBS Package Reference: <u>OPA2170AIDSGR</u>	QBS Package Reference: TPS53605DSQ	QBS Package Reference: TRS3122ERGER
-	CLHTOL (FF)	125C (1000 Hours), Abs Max (36V)	-	-	-	1/47/0	-
-	CLHTOL (FS)	125C (1000 Hours), Abs Max (36V)	-	-	-	1/33/0	-
-	CLHTOL (SF)	125C (1000 Hours), Abs Max (36V)	-	-	-	1/33/0	-
-	CLHTOL (SS)	125C (1000 Hours), Abs Max (36V)	-	-	-	1/47/0	-
- Mo	pisture Sensitivity Level, JEDEC	Level 2-260C	3/36/0	-	-	-	-
AC	Autoclave 121C	192 Hours	-	3/231/0		-	-
AC	Autoclave 121C	96 Hours	-	3/231/0	-	-	3/231/0
CDM	ESD - CDM	1000 V	-	-	3/9/0	3/9/0	-
CDM	ESD - CDM	1500 V	-	-	2/6/0	2/6/0	1/3/0
CDM	ESD - CDM	250 V	-	-	3/9/0	3/9/0	-
CDM	ESD - CDM	500 V	-	-	3/9/0	3/9/0	-
CDM	ESD - CDM	750 V	-	-	3/9/0	3/9/0	-
DS	Die Shear	QSS 009-009	-	-	-	-	3/30/0
	ectrical Characterization	Per Datasheet Parameters	-	-	1/Pass	3/90/0	1/30/0
ED	ctrical Characterization, side by side	-	1/Pass	-	-	-	-
ELFR	Early Life Failure Rate, 125C	48 Hours	-	-	-	3/2999/0	-
FLAM Fla	mmability (IEC 695-2-2)		-	-		-	3/15/0
	lammability (UL 94V-0)		-	-	•	-	3/15/0
FLAM F	lammability (UL-1694)		-	-	•	-	3/15/0
HAST	Biased HAST, 110C/85%RH	264 Hours	-	-	-	3/231/0	-
HAST	Biased HAST, 130C/85%RH	192 Hours	-	3/228/0	-	-	-
HAST	Biased HAST, 130C/85%RH	96 Hours	-	3/231/0	3/231/0	-	3/231/0
HBM	ESD - HBM	1000 V	-	-	3/9/0	3/9/0	-
HBM	ESD - HBM	1500 V	-	-	3/9/0	3/9/0	-

Туре	Test Name / Condition	Duration	Qual Device: TP S62162DSGR	QBS Package Reference: BQ294504DRVR	QBS Package Reference: OPA2170AIDSGR	QBS Package Reference: TPS53605DSQ	QBS Package Reference: TR\$3122ERGER
HBM	ESD - HBM	2000 V	-		3/9/0	3/9/0	-
HBM	ESD - HBM	2500 V	-	-	-	3/9/0	-
HBM	ESD - HBM	3000 V	-	-	3/9/0	-	-
HBM	ESD - HBM	4000 V	-	-	3/9/0	-	1/3/0
HBM	ESD - HBM	500 V	-	-	3/9/0	2/6/0	-
HTOL	Life Test, 125C	1000 Hours	-	-	-	3/231/0	-
HTOL	Life Test, 150C	300 Hours	-	-	-	-	1/77/0
HTSL	High Temp Storage Bake 150C	1000 Hours	-	-	-	-	3/231/0
HTSL	High Temp Storage Bake 170C	420 Hours	-	-	3/231/0	2/90/0	-
LU	Latch-up	(per JESD78)	-	-	-	-	1/6/0
LU	Latch-up	Latchup/125C	-	-	-	3/18/0	-
LU	Latch-up	Latchup/25c	-	-	1/6/0	-	-
MQ	Manufacturability (Assembly)	(per mfg. Site specification)	3/Pass	3/Pass	-	3/Pass	3/Pass
MQ	Manufacturability (Assembly)	(per mfg. Site specification) Request crater check	-	-	3/Pass	-	-
MQ	Manufacturability (Testability - TQ)	(per mfg. Site specification)	-	-	-	-	1/Pass
MSL	Thermal Path Integrity	Level 1-260C	-	3/36/0	-	-	-
MSL	Thermal Path Integrity	Level 2-260C	-	-	-	-	3/36/0
MSL	Thermal Path Integrity, JEDEC, L2	Elec-2/25C	-	-	1/12/0	-	-
MSL	Thermal Path Integrity, JEDEC, L2	Level 2	-	-	2/24/0	-	-
PC	PreCon Level 2	Elec/25C	-	-	3/1249/0	11/815/0	-
PC	PreCon Level 2	Level 2-260C	-	-	-	-	3/1005/0
PD	Physical Dimensions	(per mechanical drawing)	-	-	1/5/0	3/90/0	3/30/0
SD	Pb Free Solderability	Pb Free/Solderability	-	-	-	3/15/0	-
SD	Surface Mount Solderability	Pb Free	-	-	-	-	1/22/0
TC	Temperature Cycle, - 65/150C	1000 Cycles	-	3/231/0	-	-	-
TC	Temperature Cycle, - 65/150C	500 Cycles	-	3/231/0	3/231/0	3/231/0	3/231/0
TC	Temperature Cycle, - 65/150C	750 Cycles	-	3/231/0	3/231/0	-	-
UHAST	Unbiased HAST 110C/85%RH	264 Hours	-	-	-	3/231/0	-
UHAST	Unbiased HAST 130C/85%RH	96 Hours	-	-	3/231/0	-	-

Туре	Test Name / Condition	Duration	Qual Device: TP \$62162D\$GR	QBS Package Reference: BQ294504DRVR	QBS Package Reference: OPA2170AIDSGR	QBS Package Reference: TPS53605DSQ	QBS Package Reference: TRS3122ERGER
VM	Visual / Mechanical	(per mfg. Site specification)	-	-	-	-	3/984/0
VM	Visual Quality Reliability Inspection	Post 1000 Cycles Temp Cycle	-	3/6/0	-	-	-
VM	Visual Quality Reliability Inspection	Post 192 Hours HAST	-	3/6/0	-	-	-
VM	Visual Quality Reliability Inspection	Post 96 Hours HAST	-	3/6/0	-	-	-
VM	Visual Quality Reliability Inspection	Post Autoclave	-	-	-	-	3/Pass
VM	Visual Quality Reliability Inspection	Post Temp Cycle	-	-	-	-	3/Pass
WBP	Bond Pull	36 leads, 5 units/lot	-	-	-	3/228/0	-
WBP	Bond Pull	76 Wire, 3 units min	-	-	-	-	3/228/0
WBP	Bond Pull	Wires	3/228/0	3/228/0	-	-	-
WBS	Ball Bond Shear	36 leads, 5 units/lot	-	-	-	3/228/0	-
WBS	Ball Bond Shear	76 balls, 3 units min	-	-	-	-	3/228/0
WBS	Ball Bond Shear	Wires	3/228/0	3/228/0	-	-	-
XRAY	X-ray	(top side only)	-	-	-	-	3/15/0

- QBS: Qual By Similarity
   Qual Device TPS62162DSGR is qualified at LEVEL2-260CG
   Preconditioningwas performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable
   The following are equivalent HTOL options based on an activation energy of 0.7eV: 125C/1k Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours
   The following are equivalent HTSL options based on an activation energy of 0.7eV: 150C/1k Hours, and 170C/420 Hours
   The following are equivalent Temp Cycle options perJESD47:-55C/125C/700 Cycles and-65C/150C/500 Cycles
   Quality and Environmental data is available at TI's external Web site: http://www.ti.com/
   Green/Pb-free Status:
   Qualified Pb-Free(SMT) and Green

For questions regarding this notice, e-mails can be sent to the contacts shown below or your local Field Sales Representative.

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